SR2I301

Overview of Protections against IC Counterfeiting and Hardware Trojan Horses

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Outline

- IC Counterfeiting
 - Overview of the threat
 - Detection methods
 - Prevention methods
- Hardware Trojan Horses
 - Types
 - Detection methods
 - Prevention methods
- Conclusions



IC Counterfeiting is a reality

- The IC Supply chain (distributors, brokers,...) is an open door to counterfeit components [1] (SIA report)
- All sectors are impacted, including military[2] 5DoD report)
- Economic Harm
 - Reduction of the Original Component Manufacturer (OCM): market share: \$169 billion in 2012 [3]
- Damage due to lack of reliability
 - The counterfeit circuit may be defective
 - Negative image of the OCM



IC counterfeiting



Counterfeiting types [4]

- The circuit is the original one but has been illegally manipulated
- The circuit is **fake**



Counterfeiting with original circuit

IC life cycle:



Recycling

The circuit has been taken from old PCBs and remarked

Falsification

• The labeling, specification and certification are forged

Overproduction

There is no legal contract for fabrication

With defects

• The component did not pass the tests



Counterfeiting with fake circuit

IC life cycle:



- Cloning
 - The circuit has been pirated by reverse engineering and redesigned identically

Hardware Trojan Horse (HTH)

The circuit has been tampered at the fab stage and some extra logic called Hardware Trojan Horse has been added to spy or destroy it



How to protect from counterfeiting ?

- To work with trusted partners
 - Design House : to make ICs in trusted fabs
 - User : to buy ICs to trusted distributors
- To use detection techniques
 - For existing devices
 - For new devices with dedicated hardware
- To use prevention techniques
 - Only for new devices



Detection Methods [4]

- □ 3 main types:
 - Physical analysis
 - Can be destructive
 - Only used to detect recycling and forged circuits
 - Electrical tests
 - Aging tests



Detection: Physical analysis

- Imaging
 - Visual inspection
 - XRAY imaging
 - Scanning Acoustic Microscopy (ultrawave)
 - Scanning Electron Microscopy
- Material Analysis
 - XRAY fluorescence spectroscopy
 - IR spectroscopy (IR absorption)
 - THz spectroscopy (absorption in metal)



Example: X-ray Nanotomography[5]





Detection: Electrical tests

- Integrity tests
 - Scan chain to detect failures
- Parametric tests
 - DC and AC parameters in
 - In various environment
 - To detect abnormal offset
- Functionnal tests
 - To detect out of range ICs
- Burn-in test
 - Accelerate the **aging** and the failure occurence



Detection: Aging tests

Data analysis

- Delay measurement which is very sensitive to aging
- Machine Learning algorithms used to classify two sets of data:
 - New trusted devices and
 - unknown devices, presumably new
- This method is impacted by process variation
- With internal sensors
 - CDIR (Combating Die and IC recycling)
 - Differential structure
 - Ring oscillator reference vs stressed
 - Usage time measurement
 - A clock counter is stored in NVM or OTP (antifuse)



Prevention: Hardware metering

Passive Hardware metering

- Every circuit has its own ID, either in
- Non Volatile memory : can be read or tampered
- Physically Unclonable Function (PUF), which cannot be reverse engineered
- An authentication protocol is build with the ID
- Active Hardware metering
 - The circuit is initially locked. It is unlocked only if the circuit is authenticated.



13 of 43

Prevention: PUF examples





Prevention: PUF-based authentication





Prevention: locking mechanism [6]

The state graph is locked at power-up, and unlocked with the correct sequence





Prevention: Secure Split Test [7]

- To secure the manufacturing test, hence counterfeiting with defects
- The test is done by using asymmetric crypto
- The IC owner unlocked the good IC with a master key



Prevention: Split manufacturing [8]

- The chip manufacturing is split into two steps.
- □ First step:
 - Done by any foundry, not necessarily trusted
 - In charge of the "front end of line": gates and first metal layers
- Second step:
 - Done by a trusted foundry
 - In charge of finishing the connections "back end of line"
- IARPA established a new program in 2011 based on split manufacturing: "Trusted Integrated Chips" [8]



Prevention: Watermarking [10]

- To secure IP (Intellectual Property) block inside an IC
- Many ways to insert the mark:
 - GDSII
 - Pattern specific to the design
 - FPGA
 - unused LUTs in the bitstream
 - > HDL
 - Unused part of memory, or truth table combinations
 - Synthesis



Prevention: Camouflaging[11]



- Hiding of the cell layout to prevent reverse engineering by optical inspection
 - > a: NAND, b: NOR
 - c: camouflaged NAND, d: camouflaged NOR



IC Counterfeiting protection efficiency

_		Recycled	Forged	Over produced	Defective	Cloned	нтн
Detectior	Physical tests	**	**				
	Electrical tests	**	**		*	*	*
	Aging tests	*	*				
revenuon	HW metering			*		*	
	Secure split test			**	**	*	
	Split manufacturing			*		*	*
	Watermarking					*	
	Camouflaging					*	



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HTH: A powerful and pernicious threat

HTH:

- Insertion in an IC of Hardware unknown to the designer
- Goal: spying, disturbing, destroying
- Can be inserted at all the levels of the IC design chain
- □ It is not only an economic threat, it is also strategic
 - 2007 DARPA program "Trust in Ics"
 - 2011 IARPA program" Trusted Integrated Chips"[8] exloiting split manufacturing
- But it is also a weapon for the designer:
 - Backdoors



HTH Principle



- Two components:
 - TRIGGER: Reads and decode internal and rare state
 - PAYLOAD: Writes internal data
- HTH acts as a probing station, both passive (trigger) and active (payload), and is stealthy



HTH Payload examples[12]

- Kill switch
 - Simple payload, desastrous effect as Denial of Services
- Deteriorate the performances
 - Accelerate the aging, add extra delays
- Create leakages
 - Create an access to secret data, either by a functionnal channel or a side-channel
- Assist malwares
 - Exploits a hidden function. The HTH is called backdoor if the designer is the creator.



HTH Triggering examples

- Combinatorial
 - Decoding of rare event from multiple nodes
 - trigger = f(nodes)
 - Use significant number of gates
- Sequential
 - Decoding of a rare event from sequential variables
 - Trigger = f(nodes, time)
 - Less nodes but a few flip-flops
- Analog
 - Use internal sensors and external parameters
 - Example: Trigger temperature > threshold
 - Need few gates



HTH Taxonomy [13]

Insertion stage

Specification, design, fabrication, test, assembly

Abstraction level

RTL, gate, layout, physical,

Trigger type

Combinatorial, sequential, analog

Payload type

- New behavior, less performance, leakages, DoS
- Physical characteristics
 - Size, distribution, parametric, functionnal, same layout



HTH protection overview [14]





HTH detection by optical method[15]

Needs a GDSII golden model



Trojan size = 1 AND gate

AES

Trojan size = 128 AND gate

Comparison between an original GDSII and a trojaned IC with a ×150 lens confocal microscope



HTH detection by optical method

Cross correlation between the original AES layout and an affected AES layout

		Hardware Trojan size (Nb of AND gates)								
		1	2	4	8	16	32	64	128	
	50%	0.9991	0.9972	0.9981	0.9950	0.9933	0.9918	0.9815	0.9668	
	60%	0.9987	0.9968	0.9959	0.9955	0.9944	0.9893	0.9788	0.9670	
	70%	0.9989	0.9981	0.9918	0.9941	0.9881	0.9850	0.9594	0.9067	
Core utilization rate	80%	0.9999	0.9965	0.9898	0.9957	0.9780	0.9711	0.8970	0.8509	
	90%	0.9988	0.9990	0.9983	0.9962	0.9832	0.9572	0.8858	0.4010	
	95%	0.9997	0.9984	0.9980	0.9889	0.9589	0.9115	0.8824	0.8202	
	99%	0.9917	0.938	0.9714	0.9527	0.3798	NC	NC	NC	

In black: ECO routing

Trojan almost impossible to insert without changing the layout, if occupancy rate > 80%



HTH detection at test time

Logic Testing

- To search the triggering of the Trojan
- Need exhaustive search of a rare event => impossible
- Rather use statistical approaches as MERO[15]
- Or add HW to avoid rare event

Side Channel

- To detect the resources of the Trojan
- By measuring:
 - the Current (IDDQ, IDDT)
 - the EM field
 - the propagation delays
- Very sensitive to noise and process variance



HTH detection with side-channel[17]

- Needs a golden model of the "activity"
- Measurement of local EM field with RF probes
- Impact of noise => Probability of detection





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HTH detection with side-channel





□ HTH of different sizes: HTH greater than 1% can be detected with a false negative rate of 0.017%.



HTH detection at run time

- Techniques to check the integrity in real time
- Can take advantage of SEU and attack detection techniques :
 - Error correction codes
 - Control Flow Integrity (processors)
 - Hardware Assertions checkers
 - Real time security monitor

34 of 43

HTH detection by flow integrity check[18]

- The processor control flow can be tampered by HTH and/or malwares
- Prevention can check the integrity of basic blocks and unexpected jumps
 - Example: Use golden tables of basic blocks CRC and jump tables





HTH detection at run time: assertions[19]



- Example: The HTH outputs a secret key with on the UART channel by doubling the Baudrate
- Property to check by Hardware:
 - The serial bits have to be stable during a fixed period.
 - If the baudrate changes, the assertion fails



HTH prevention

Split manufacturing

- Use a "root of trust" with two steps: Front-end of line, and Back end of line
- To use the layout-filler
- No more places to insert HTH on GDSII
- □ To avoid rare events during test time

Obfuscation

- To obfuscate the state transitions by keys
 - Active Hardware metering
- To obfuscate by error correcting codes (ECC)
 - Mask the signals with random variables



Encoding the circuit [20]

- Principle:
 - The HTH has two parts:
 - probing (trigger) and fault injection (payload)
 - The registers are the most easy cells to detect, thus the most easy to probe for Trojan insertion
 - The sequential variables in registers are encoded by Linear Complementary Dual Codes (LCD)
 - The Dual code allows the designer to use random variables to mask the real computation
- Protection also effective against:
 - Probing attacks
 - Fault attacks
 - Side-Channel Attacks



Encoding the circuit: Architecture





39 of 43

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Encoding the circuit: Methods

- G encodes k bits
- H is the dual of G
 - (GH^T=0)
- Encoding:
 - Z=xG xor yH \succ
 - X=information
 - Y=random variable
- Decoding*
 - J=GT(GGT)-1
 - K=HT (HHT)-1
 - * Moore-Penrose pseudo-inverse



Encoding the circuit: Security Proof

- The code [n,k,d] has a proven security of d:
 - The HTH trigger is inefficient with less than d probes
 - The HTH payload is inefficient if it modifies less than d nets
- Complexity
 - Choose low density codes to encode and decode





Table 8.6 – Synthesis results of encoded circuit method, and security parameters for the SIMON co-processor.

IC (Code)	Gates	Area (μm^2)	n	k	$d_{\mathbf{Trigger}}$	$d_{\mathbf{Payload}}$
Original ([109,109,1])	300	1919	109	109	1	1
Encoded ([110,109,2,1])	560	3567	110	109	2	1
Encoded $([140, 109, 10, 6])$	3107	20239	140	109	10	6
Encoded ([123,109,5,3])	2348	15249	123	109	5	3



Conclusions

- Methods for counterfeiting and HTH insertions are sophisticated and increasing.
- Many protections:
 - But need resources:
 - Tools and methods for detection
 - Extra Silicon and methods for prevention
 - Split foundries
 - The optimal solution is still a challenge
 - Combination of techniques
 - With reduced complexity to get higher detection or avoidance rate
 - But very few inputs from the industrials



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